

Silicon Carbide Power MOSFET **E-Series Automotive** N-Channel Enhancement Mode

Features

- 3rd generation SiC MOSFET technology
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q,,)
- Halogen free, RoHS compliant
- Automotive Qualified (AEC-Q101) and PPAP Capable

Benefits

- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency

Applications

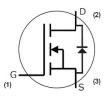
- **EV Battery Chargers**
- High Voltage DC/DC Converters

Package









Part Number	Package	Marking	
E3M0060065D	TO-247-3L	E3M0060065D	

Maximum Ratings ($T_c = 25$ °C unless otherwise specified)

Symbol	Parameter	Value	Unit	Note	
V_{DSmax}	Drain - Source Voltage		650	V	
V_{GSmax}	Gate - Source Voltage		-8/+19	V	Note: 1
	Continuous Dunin Comment V. 15 V.	T _C = 25°C	37		Fig. 19
I _D	Continuous Drain Current, V _{GS} = 15 V		26		Note: 2
I _{D(pulse)}	Pulsed Drain Current, Pulse width t _p limited by T _{jmax}	99	А	Fig. 22	
P _D	Power Dissipation, $T_c = 25^{\circ}C$, $T_J = 175^{\circ}C$	131	W	Fig. 20 Note: 2	
T_{J},T_{stg}	Operating Junction and Storage Temperature			°C	
T _L	Solder Temperature, 1.6mm (0.063") from case for 10s			°C	
M _d	Mounting Torque , M3 or 6-32 screw	1 8.8	Nm Ibf-in		

Note (1): Recommended turn off / turn on gate voltage V_{GS} - 4V...0V / +15V

Note (2): Verified by design

Electrical Characteristics $(T_c = 25^{\circ}C \text{ unless otherwise specified})$

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	Note
V _{(BR)DSS}	Drain-Source Breakdown Voltage	650			V	$V_{GS} = 0 \text{ V, } I_D = 100 \mu\text{A}$	
$V_{GS(th)}$	Gate Threshold Voltage	1.8	2.8	3.6	V	$V_{DS} = V_{GS}$, $I_D = 3.6 \text{ mA}$	Fig. 11
V GS(th)	date miesnoid voltage		2.2		V	$V_{DS} = V_{GS}$, $I_D = 3.6 \text{ mA}$, $T_J = 175 ^{\circ}\text{C}$	Fig. 11
I _{DSS}	Zero Gate Voltage Drain Current		1	50	μΑ	$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$	
I _{GSS}	Gate-Source Leakage Current		10	250	nA	$V_{GS} = 15 \text{ V}, V_{DS} = 0 \text{ V}$	
$R_{DS(on)}$	Drain-Source On-State Resistance		60	79	mΩ	$V_{GS} = 15 \text{ V}, I_D = 13.2 \text{ A}$	Fig. 4,
DS(on)	Drain Source on State nesistance		83		11122	V _{GS} = 15 V, I _D = 13.2 A, T _J = 175°C	5, 6
g fs	Transconductance		9		S	V _{DS} = 20 V, I _{DS} = 13.2 A	Fig. 7
			9			V_{DS} = 20 V, I_{DS} = 13.2 A, T_{J} = 175°C	1
C _{iss}	Input Capacitance		1170				
Coss	Output Capacitance		72		рF	$V_{GS} = 0 \text{ V}, V_{DS} = 0 \text{V to } 600 \text{ V}$	Fig. 17, 18
C_{rss}	Reverse Transfer Capacitance		6		[F = 1 Mhz	
E _{oss}	Coss Stored Energy		14		μЈ	V _{AC} = 25 mV	Fig. 16
C _{o(er)}	Effective Output Capacitance (Energy Related)		85		pF		Note: 3
$C_{o(tr)}$	Effective Output Capacitance (Time Related)		122		рF	$V_{GS} = 0 \text{ V}, V_{DS} = 0400 \text{ V}$	
E _{on}	Turn-On Switching Energy (External Diode)		126			$V_{DS} = 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}, I_D = 13.2 \text{A},$	
E _{OFF}	Turn Off Switching Energy (External Diode)		25		ί μ)	$R_{G(ext)} = 2.5 \Omega$, L= 135 μH, $T_J = 175$ °C FWD = External SiC DIODE	Fig. 26
E _{on}	Turn-On Switching Energy (Body Diode FWD)		169			$V_{DS} = 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}, I_D = 13.2 \text{A},$	
E _{OFF}	Turn-Off Switching Energy (Body Diode FWD)		23		ί μ)	$R_{G(ext)} = 2.5 \Omega$, L= 135 μH, $T_J = 175$ °C FWD = Internal Body Diode	Fig. 26
t _{d(on)}	Turn-On Delay Time		10				Fig. 27
t _r	Rise Time		33			$V_{DD} = 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$ $I_D = 13.2 \text{ A}, R_{G(ext)} = 2.5 \Omega,$	
t _{d(off)}	Turn-Off Delay Time		17		l ns	Timing relative to V _{DS}	
t _f	Fall Time		8			- Inductive load	
$R_{G(int)}$	Internal Gate Resistance		4		Ω	f = 1 MHz, V _{AC} = 25 mV	
Q_{gs}	Gate to Source Charge		16			$V_{DS} = 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$	
Q_{gd}	Gate to Drain Charge		13		$V_{DS} = 400 \text{ V}, V_{GS} = -4 \text{ V/ 15 V}$ $I_D = 13.2 \text{ A}$		Fig. 12
Q_g	Total Gate Charge		46	1		Per IEC60747-8-4 pg 21	

Note (3): $C_{O(er)}$, a lumped capacitance that gives same stored energy as Coss while Vds is rising from 0 to 400V $C_{O(tr)}$, a lumped capacitance that gives same charging time as Coss while Vds is rising from 0 to 400V

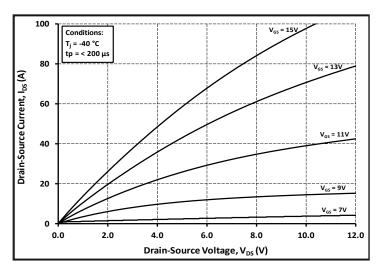
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Reverse Diode Characteristics ($T_c = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note	
V		4.6		V	$V_{GS} = -4 \text{ V}, I_{SD} = 6.6 \text{ A}, T_{J} = 25 ^{\circ}\text{C}$	Fig. 8,	
V_{SD}	Diode Forward Voltage	4.1		V	$V_{GS} = -4 \text{ V, } I_{SD} = 6.6 \text{ A, } T_{J} = 175 ^{\circ}\text{C}$		
I _S	Continuous Diode Forward Current		23	Α	$V_{GS} = -4 \text{ V}, T_C = 25^{\circ}\text{C}$		
ls, pulse	Diode pulse Current		99	Α	$V_{GS} = -4 \text{ V}$, pulse width t_P limited by T_{jmax}		
t _{rr}	Reverse Recover time	23		ns			
Q _{rr}	Reverse Recovery Charge	108		nC	$V_{CS} = -4 \text{ V, } I_{SD} = 13.2 \text{ A, } V_{R} = 400 \text{ V}$ $dif/dt = 1720 \text{ A/}\mu\text{s, } T_{J} = 175 \text{ °C}$		
I _{rrm}	Peak Reverse Recovery Current	8		А			
t _{rr}	Reverse Recover time	30		ns			
Q _{rr}	Reverse Recovery Charge	97		nC	$V_{GS} = -4 \text{ V, } I_{SD} = 13.2 \text{ A, V}_{R} = 400 \text{ V}$ dif/dt = 790 A/µs, $T_{L} = 175 \text{ °C}$		
I	Peak Reverse Recovery Current	6		А			

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	1.02	1.14	°C/W		Fig. 21



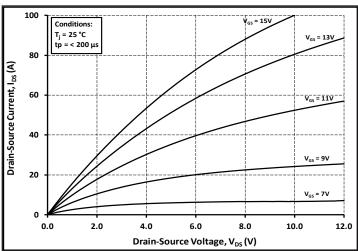
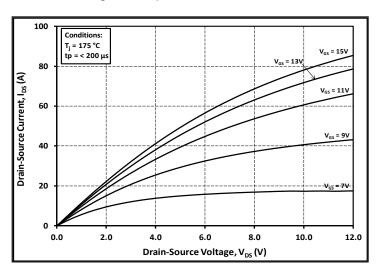


Figure 1. Output Characteristics T_J = -40 °C

Figure 2. Output Characteristics T_J = 25 °C



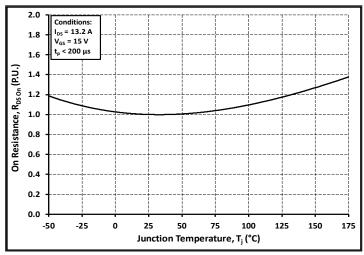
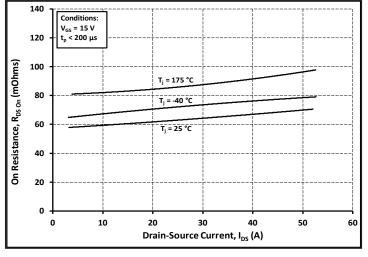


Figure 3. Output Characteristics T_J = 175 °C

Figure 4. Normalized On-Resistance vs. Temperature



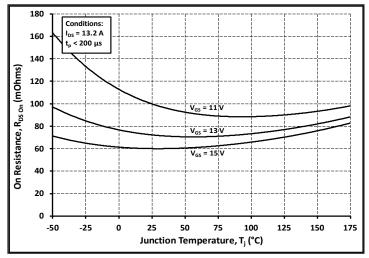
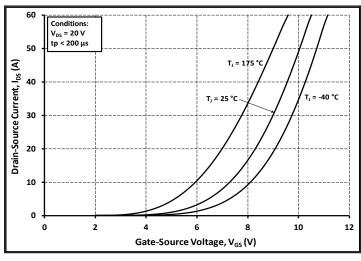


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

Figure 6. On-Resistance vs. Temperature For Various Gate Voltage



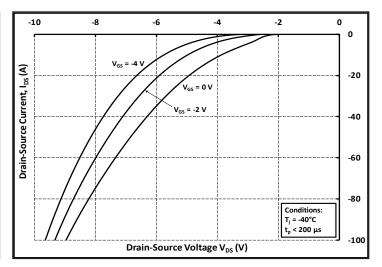
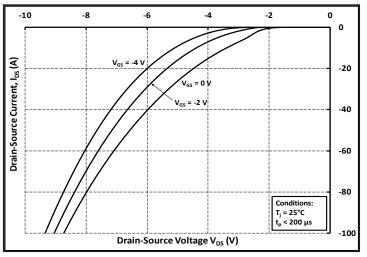


Figure 7. Transfer Characteristic for Various Junction Temperatures

Figure 8. Body Diode Characteristic at -40 °C



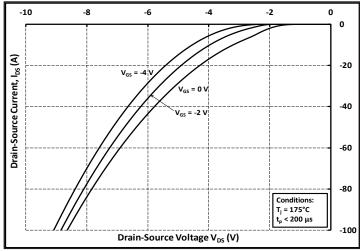
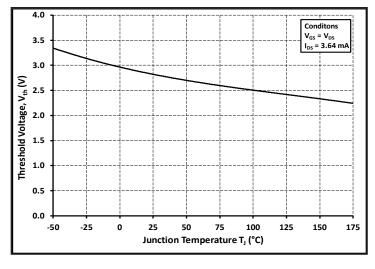


Figure 9. Body Diode Characteristic at 25 °C

Figure 10. Body Diode Characteristic at 175 °C



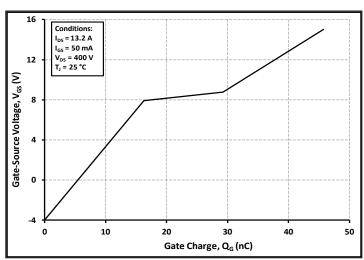


Figure 11. Threshold Voltage vs. Temperature

Figure 12. Gate Charge Characteristics

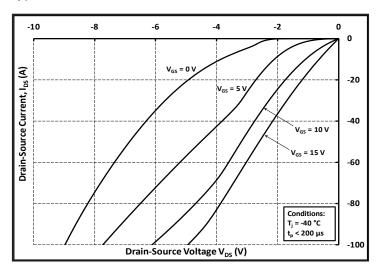


Figure 13. 3rd Quadrant Characteristic at -40 °C

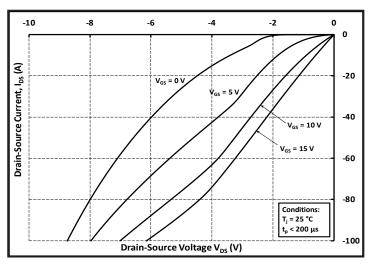


Figure 14. 3rd Quadrant Characteristic at 25 °C

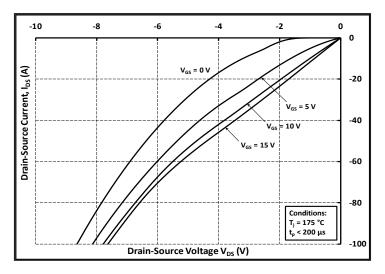


Figure 15. 3rd Quadrant Characteristic at 175 °C

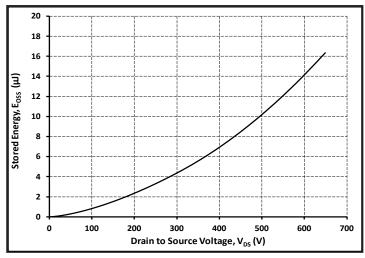


Figure 16. Output Capacitor Stored Energy

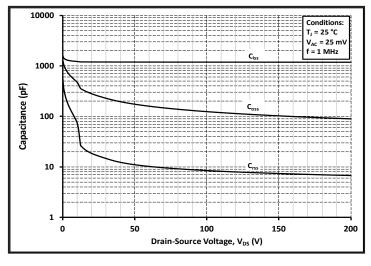


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

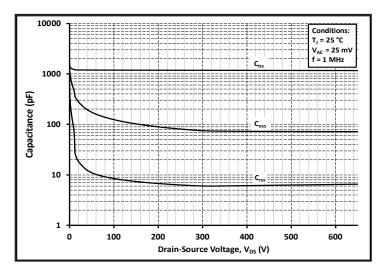
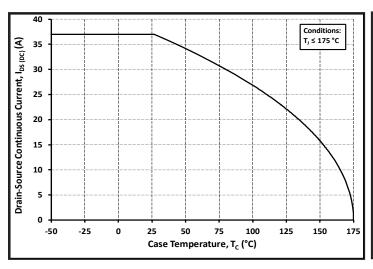


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 650V)



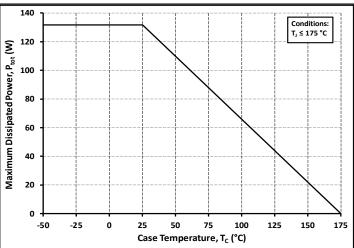
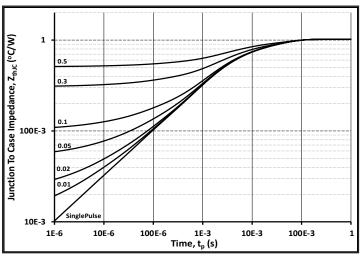


Figure 19. Continuous Drain Current Derating vs.

Case Temperature

Figure 20. Maximum Power Dissipation Derating vs. Case Temperature



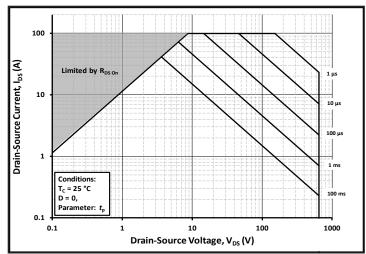
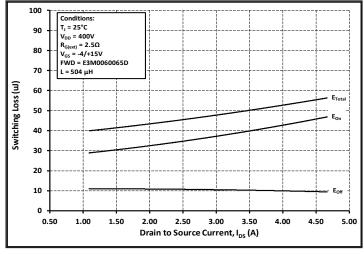


Figure 21. Transient Thermal Impedance (Junction - Case)

Figure 22. Safe Operating Area



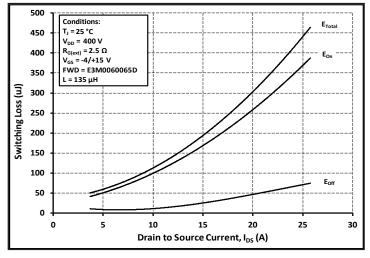


Figure 23. Clamped Inductive Switching Energy vs. Low Drain Current ($V_{DD} = 400V$)

Figure 24. Clamped Inductive Switching Energy vs. High Drain Current ($V_{DD} = 400V$)

Typical Performance

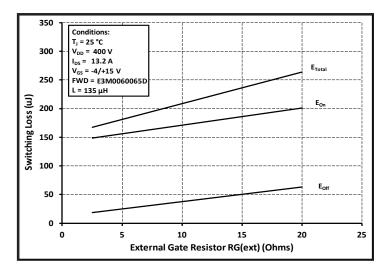


Figure 25. Clamped Inductive Switching Energy vs. $R_{G(ext)}$

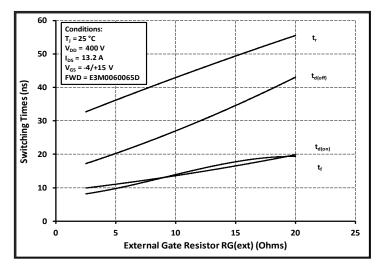
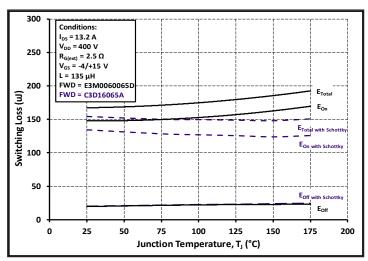


Figure 27. Switching Times vs. $R_{G(ext)}$



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Figure 26. Clamped Inductive Switching Energy vs.
Temperature

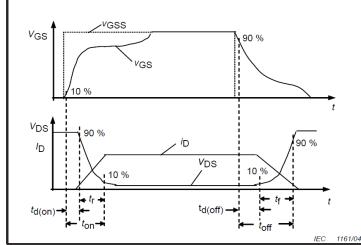


Figure 28. Switching Times Definition

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Test Circuit Schematic

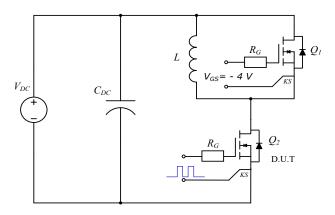
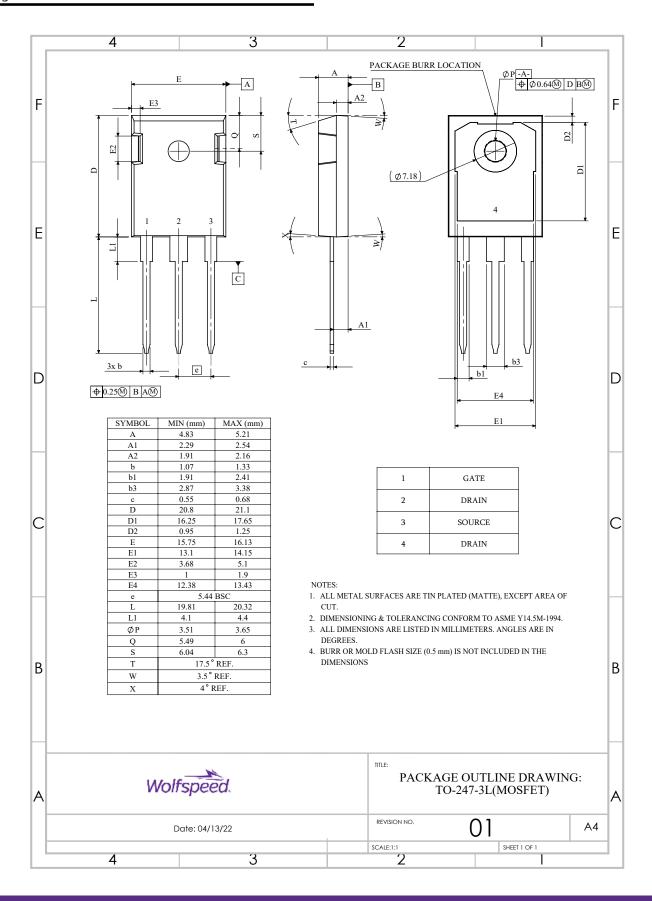
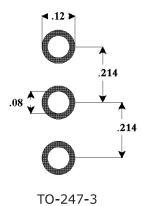


Figure 29. Clamped Inductive Switching Waveform Test Circuit

Package Dimensions



Recommended Solder Pad Layout



Revision history	
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Document Version	Date of release	Descriptiion of changes
1.0	June-2022	Initial datasheet

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